

650V Silicon Carbide Power MOSFET
Features

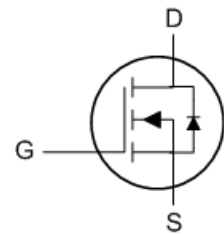
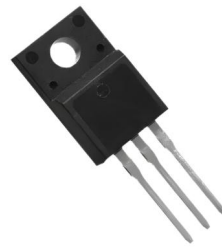
- Revolutionary semiconductor material Silicon Carbide
- High blocking voltage with low on-resistance
- High-speed switching with very low switching losses
- High-speed and high robust intrinsic body diode
- Optimized package with separate driver source pin

Product Summary


BVDSS	RDS(on)	ID
650V	260mΩ	15.5A

Applications

- LED Driver
- PD charger
- PC adapter
- Air-conditioning
- E-bike charger

TO220F Pin Configuration

Maximum Ratings For MOSFET ($T_{vj} = 25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Testing Conditions
V_{DS}	Drain-Source Voltage	650	V	
I_D	Continuous DC Drain Current for $R_{th(j-c,typ.)}$, Limited by $T_{vj(max)}$	15.5	A	$T_c = 25^{\circ}\text{C}$
		11		$T_c = 100^{\circ}\text{C}$
I_{DM}	Peak Drain Current, tp Limited by $T_{vj(max)}$	25	A	$T_c = 25^{\circ}\text{C}$
$V_{GS, max}$	Gate-Source Max Voltage	-10/22	V	
$V_{GS, op}$	Gate-Source Operate Voltage	0/15	V	
E_{AS}	Single Pulse Avalanche Energy	25	mJ	$L=0.5\text{ mH}$, $I_{AS}=10\text{ A}$, $V_{DD}=50\text{ V}$, $V_{GS}=15\text{ V}$
P_{tot}	Power Dissipation for $R_{th(j-c,typ.)}$	67	W	$T_c = 25^{\circ}\text{C}$

Package Values

Symbol	Parameter	Min.	Typ.	Max.	Unit	Testing Conditions
$R_{th(j-c)}$	MOSFET/Body Diode Junction-Case Thermal Resistance		2.23	2.67	K/W	
T_{vj} , T_{STG}	Operating Junction and Storage Temperature	-55		175	$^{\circ}\text{C}$	
T_{SOLD}	Soldering Temperature, Wave Soldering only Allowed at Leads 1.6mm from Case for 10s		260		$^{\circ}\text{C}$	

650V Silicon Carbide Power MOSFET
MOSFET Characteristics ($T_{VJ} = 25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Testing Conditions	
$V_{(BR)DSS}$	Drain-Source breakdown voltage	650			V	$I_D = 100\ \mu\text{A}$	
$V_{GS(th)}$	Gate Threshold Voltage	3.2	4.1	5	V	$V_{DS} = V_{GS}, I_D = 10\ \text{mA}$	$T_{VJ} = 25^{\circ}\text{C}$
			2.9				$T_{VJ} = 175^{\circ}\text{C}$
I_{DSS}	Drain-Source Leakage Current		0.1	20	μA	$V_{GS} = 0\ \text{V}, V_{DS} = 650\ \text{V}$	$T_{VJ} = 25^{\circ}\text{C}$
			0.5				$T_{VJ} = 175^{\circ}\text{C}$
I_{GSS}	Gate-Source Leakage Current			250	nA	$V_{GS} = 22\ \text{V}, V_{DS} = 0\ \text{V}$	$T_{VJ} = 25^{\circ}\text{C}$
I_{SGS}	Source-Gate Leakage Current			250	nA	$V_{GS} = -10\ \text{V}, V_{DS} = 0\ \text{V}$	$T_{VJ} = 25^{\circ}\text{C}$
$R_{DS(on)}$	Drain-Source On-State Resistance		260	300	m Ω	$V_{GS} = 15\ \text{V}, I_D = 5\ \text{A}$	$T_{VJ} = 25^{\circ}\text{C}$
			231				$T_{VJ} = 175^{\circ}\text{C}$
g_{fs}	Transconductance		3.6		S	$V_{DS} = 20\ \text{V}, I_D = 5\ \text{A}$	
$R_{G(int)}$	Internal Gate Resistance		25.5		Ω	$f = 1\text{MHz}, V_{AC} = 25\ \text{mV}$	
C_{iss}	Input Capacitance		294		pF	$V_{GS} = 0\ \text{V}, V_{DS} = 650\ \text{V}, f = 1\text{MHz}$	
C_{oss}	Output Capacitance		25		pF		
C_{rss}	Reverse Transfer Capacitance		4		pF		
Q_{GS}	Gate to Source Charge		4.3		nC	$V_{GS} = 0/15\ \text{V}, V_{DS} = 400\text{V}, I_D = 5\ \text{A}$	
Q_{GD}	Gate to Drain Charge		1.6		nC		
Q_G	Total Gate Charge		12.5		nC		

Dynamic MOSFET Characteristics ($T_{VJ} = 25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Testing Conditions	
$t_{d(on)}$	Turn-On Delay Time		6.6		ns	$V_{GS} = 0/15V$ $L=600uH$ $V_{DS} = 400\ V, I_D = 5\ A,$ $R_{G(on)} = 2.2\ \Omega, R_{G(off)} = 2.2\ \Omega$	$T_{VJ} = 25\ ^\circ C$
			6.0				$T_{VJ} = 175\ ^\circ C$
t_r	Rise Time		18.3		ns		$T_{VJ} = 25\ ^\circ C$
			14.2				$T_{VJ} = 175\ ^\circ C$
$t_{d(off)}$	Turn-Off Delay Time		17.7		ns		$T_{VJ} = 25\ ^\circ C$
			21.3				$T_{VJ} = 175\ ^\circ C$
t_f	Fall Time		32.1		ns		$T_{VJ} = 25\ ^\circ C$
			35.6				$T_{VJ} = 175\ ^\circ C$
E_{on}	Turn-On Switching Loss		43.2		μJ		$T_{VJ} = 25\ ^\circ C$
			40.7				$T_{VJ} = 175\ ^\circ C$
E_{off}	Turn-Off Switching Loss		5.5		μJ		$T_{VJ} = 25\ ^\circ C$
			5.2				$T_{VJ} = 175\ ^\circ C$
E_{tot}	Total Switching Energy		48.7		μJ		$T_{VJ} = 25\ ^\circ C$
			45.9				$T_{VJ} = 175\ ^\circ C$

Note: E_{on}/E_{off} result is with body diode.

Maximum Ratings For Body Diode ($T_{VJ} = 25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Testing Conditions
V_{DSS}	Drain-Source Voltage	650	V	
I_S	Continuous DC Source Current, Limited by $T_{VJ(max)}$	12	A	$T_C = 25^{\circ}\text{C}$
		7	A	$T_C = 100^{\circ}\text{C}$
I_{SM}	Peak Reverse Drain Current, tp Limited by $T_{VJ(max)}$	23	A	$T_C = 25^{\circ}\text{C}$

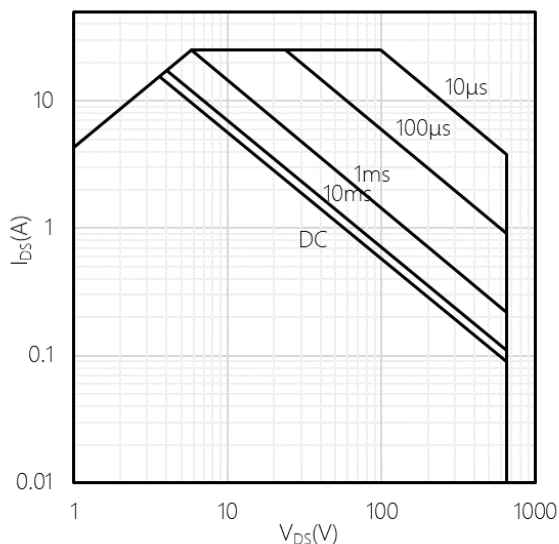
Body Diode Characteristics ($T_{VJ} = 25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Testing Conditions	
V _{SD}	Body Diode Forward Voltage		3.3		V	V _{GS} = 0 V, I _{SD} = 2.5 A	T _{VJ} = 25 °C
			2.8				T _{VJ} = 175 °C
I _{rrm}	Peak Reverse Recovery Current		5.8		A	V _{DS} = 400 V, V _{GS} = -0 V, I _{SD} = 5 A, di/dt = 1.6kA/μs	T _{VJ} = 25 °C
			6.2				T _{VJ} = 175 °C
Q _{rr}	Reverse Recovery Charge		32.6		nC		T _{VJ} = 25 °C
			36.1				T _{VJ} = 175 °C
t _{rr}	Reverse Recovery Time		9.9		ns		T _{VJ} = 25 °C
			9.4				T _{VJ} = 175 °C
E _{rr}	Reverse Recovery Energy		0.31		μJ		T _{VJ} = 25 °C
			0.39				T _{VJ} = 175 °C

Typical Performances

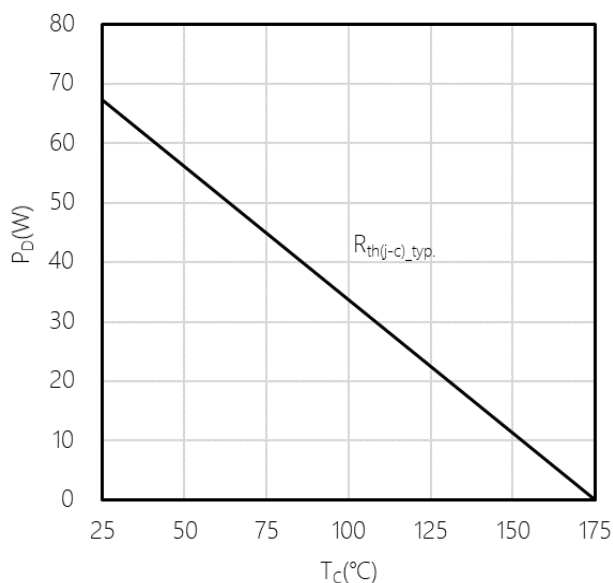
Safe operating area (SOA)

$R_{th(j-c)} = 2.67\text{ }^{\circ}\text{C/W}$, Single Pulse, $T_{vj} = 25^{\circ}\text{C}$



Power dissipation as a function of case temperature limited by bond wire

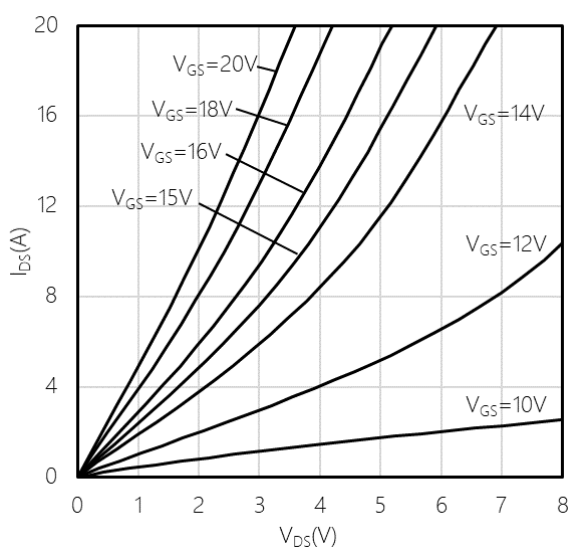
$P_D = f(T_C)$



Typical output characteristic, V_{GS} as parameter

$I_{DS} = f(V_{DS})$

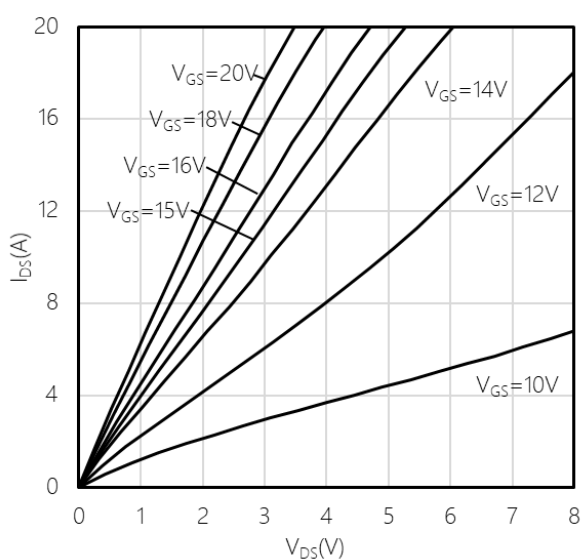
$T_{vj} = -55^{\circ}\text{C}$



Typical output characteristic, V_{GS} as parameter

$I_{DS} = f(V_{DS})$

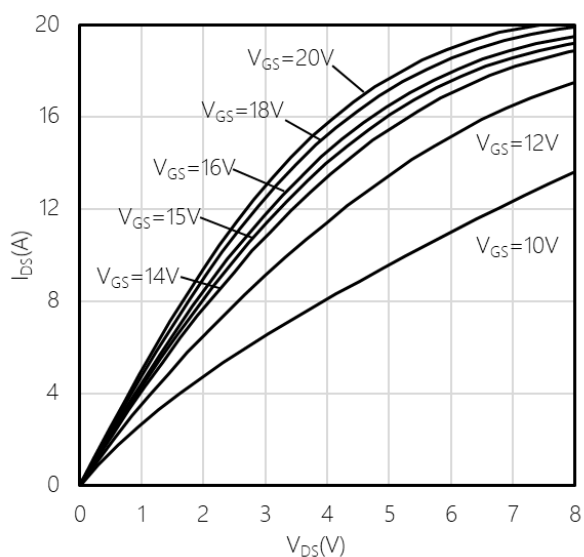
$T_{vj} = 25^{\circ}\text{C}$



Typical output characteristic, V_{GS} as parameter

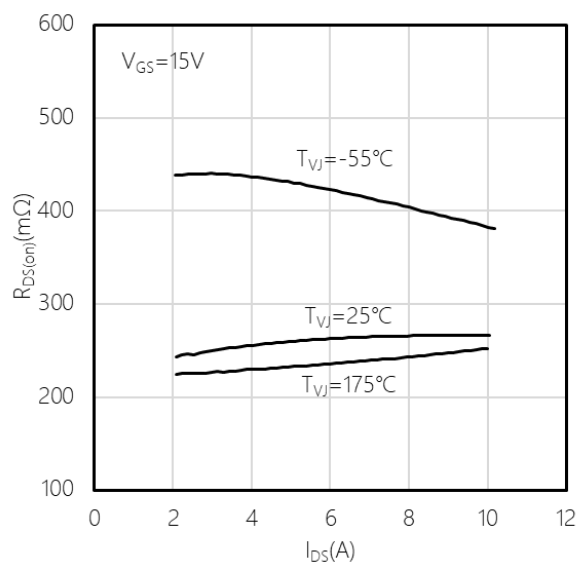
$$I_{DS} = f(V_{DS})$$

$$T_{VJ} = 175^{\circ}\text{C}$$



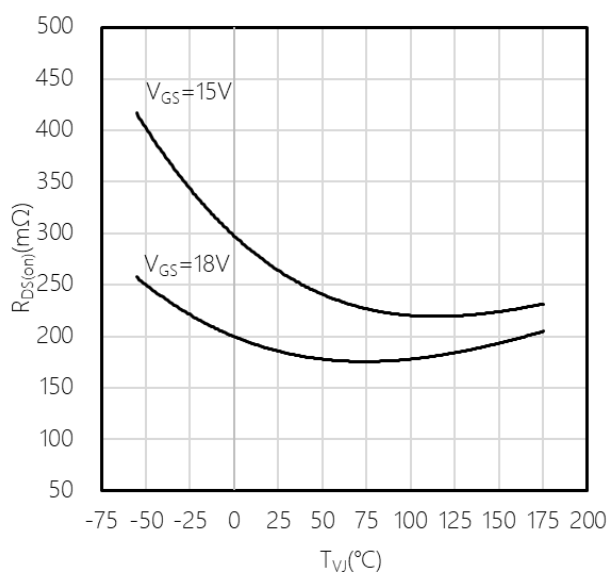
Typical on-state resistance as a function of drain current

$$R_{DS(on)} = f(I_{DS}), V_{GS} = 18\text{V}$$



Typical on-state resistance as a function of temperature

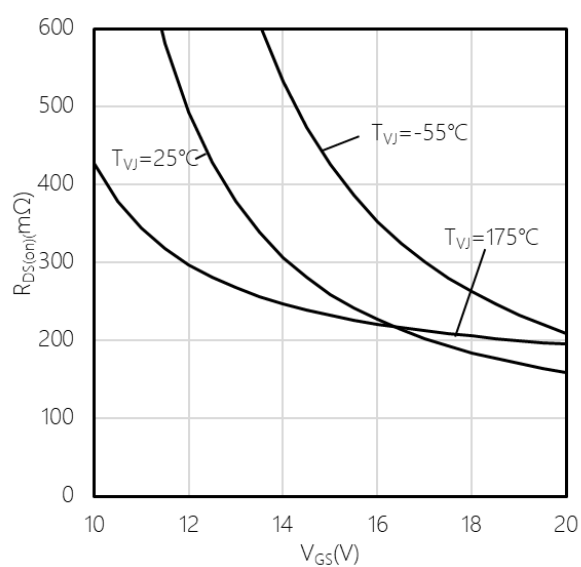
$$R_{DS(on)} = f(T_{VJ}), I_{DS} = 5\text{ A}$$



Typical on-state resistance as a function of V_{GS}

$$R_{DS(on)} = f(V_{GS})$$

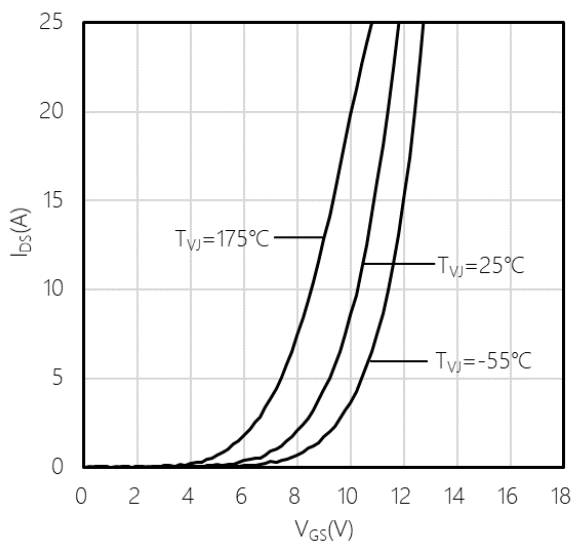
$$I_{DS} = 5\text{ A}$$



Typical transfer characteristic

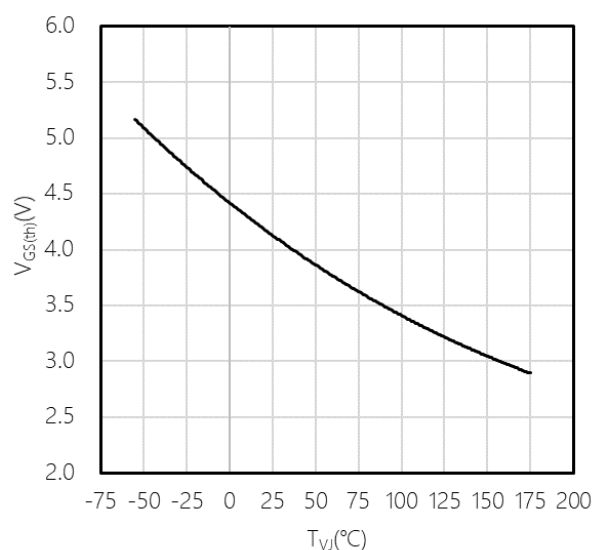
$$I_{DS} = f(V_{GS})$$

$$V_{DS} = 20 \text{ V}$$



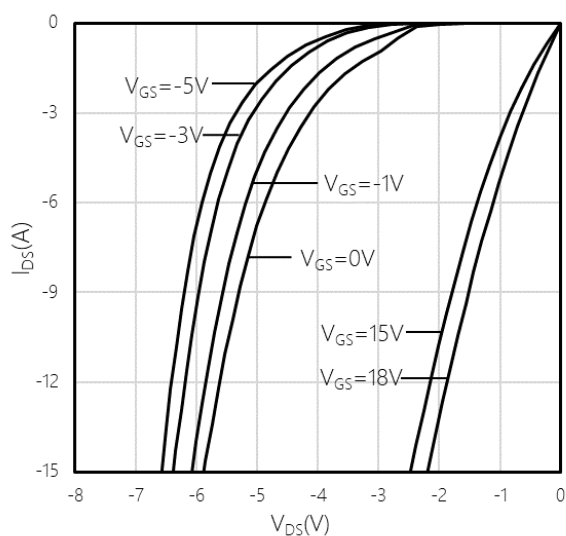
Typical gate-source threshold voltage as a function of junction temperature

$$V_{GS(th)} = f(T_{VJ}), I_{DS} = 10 \text{ mA}$$



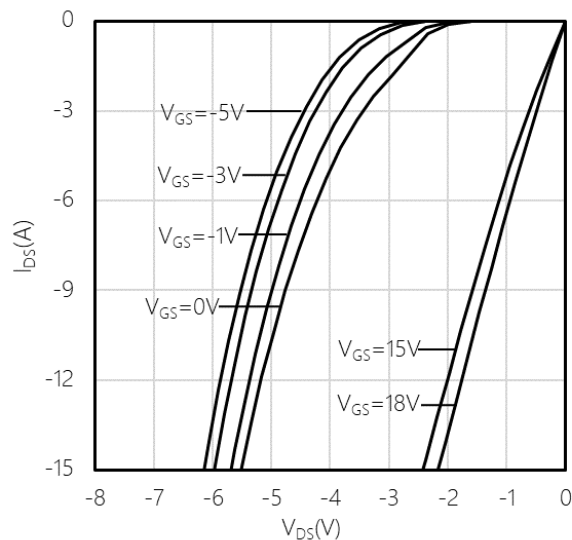
Typical reverse drain current as function of reverse drain voltage, V_{GS} as parameter

$$I_{DS} = f(V_{DS}), T_{VJ} = -55^{\circ}\text{C}$$



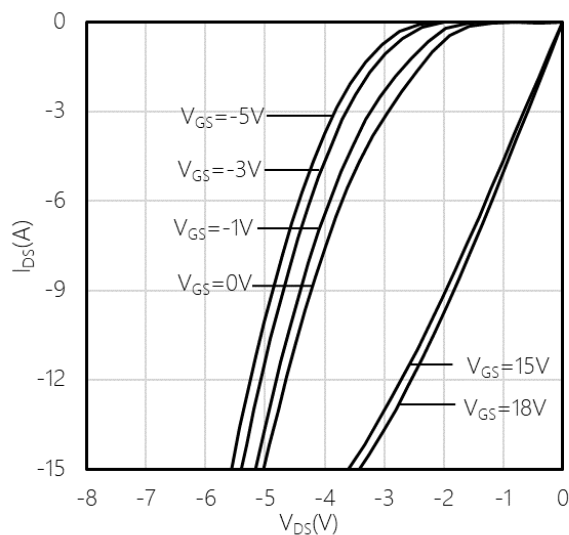
Typical reverse drain current as function of reverse drain voltage, V_{GS} as parameter

$$I_{DS} = f(V_{DS}), T_{VJ} = 25^{\circ}\text{C}$$



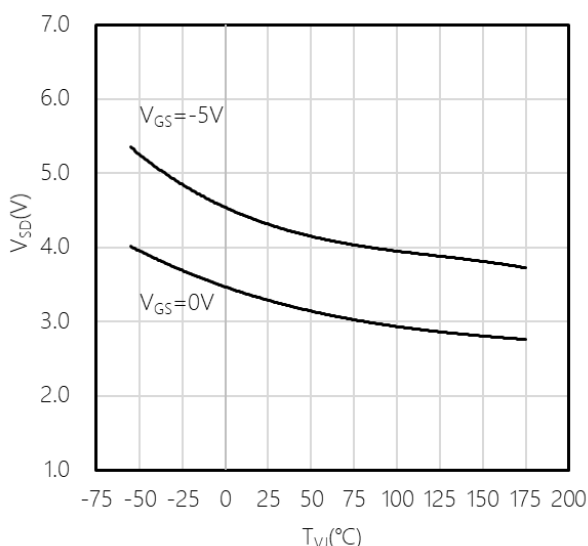
Typical reverse drain current as function of reverse drain voltage, V_{GS} as parameter

$I_{DS} = f(V_{DS}), T_{VJ} = 175\text{ }^{\circ}\text{C}$



Typical reverse drain voltage as function of junction temperature

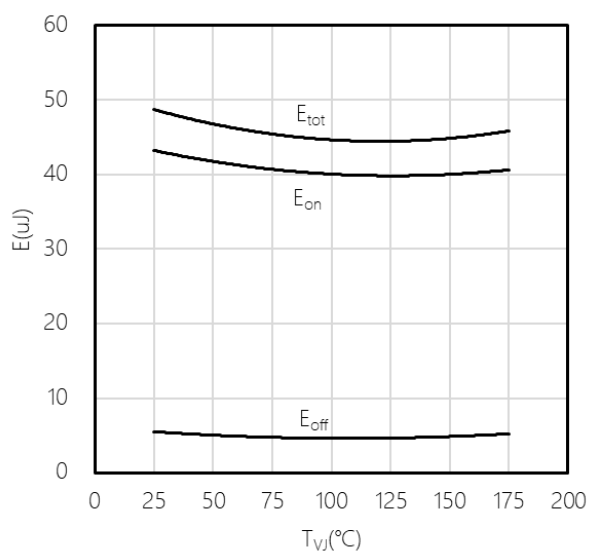
$V_{SD} = f(T_{VJ}), I_{SD} = 2.5\text{ A}$



Typical switching energy as a function of junction temperature, 2nd device own body diode: $V_{GS} = -5\text{ V}$

$E = f(T_{VJ})$

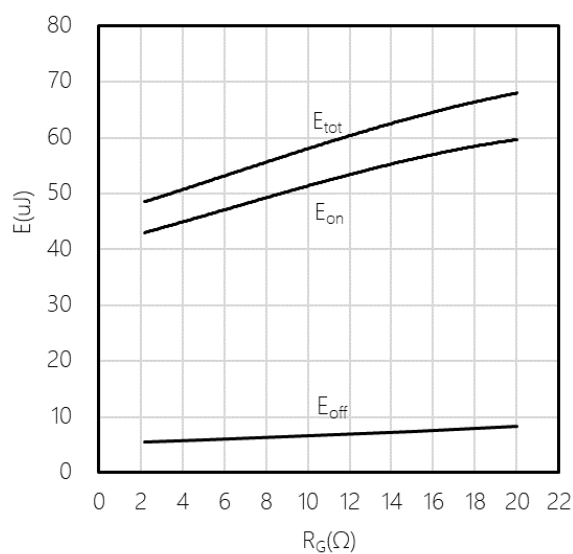
$V_{DS} = 400\text{ V}, R_{G(ext)} = 2.2\text{ }\Omega, V_{GS} = 0/15\text{ V}, I_{DS} = 5\text{ A}$



Typical switching energy losses as a function of gate resistance, 2nd device own body diode: $V_{GS} = -5\text{ V}$

$E = f(R_{G(ext)})$

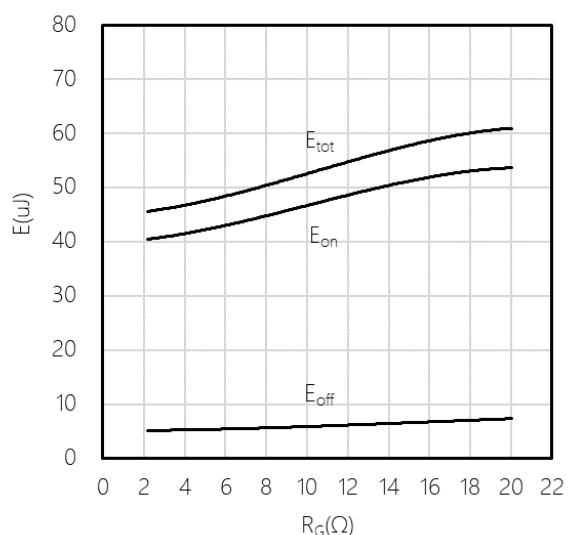
$V_{VGS} = 0/15\text{ V}, I_{DS} = 5\text{ A}, T_{VJ} = 25\text{ }^{\circ}\text{C}, V_{DS} = 400\text{ V}$



Typical switching energy losses as a function of gate resistance, 2nd device own body diode: $V_{GS} = 0$ V

$$E = f(R_{G(ext)})$$

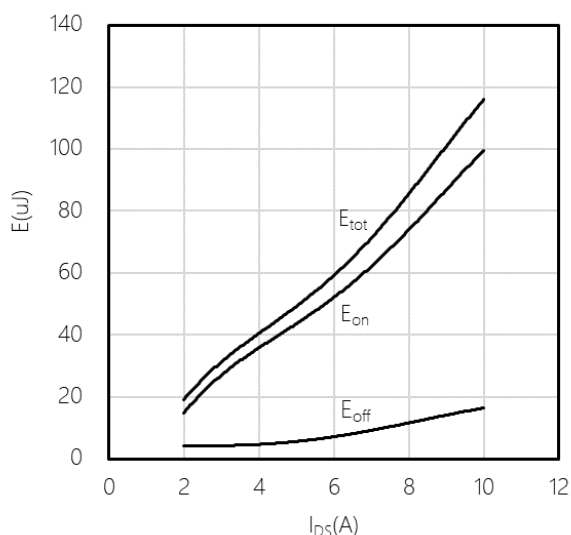
$V_{GS} = 0/15$ V, $I_{DS} = 5$ A, $T_{VJ} = 175$ °C, $V_{DS} = 400$ V



Typical switching energy losses as a function of I_{DS} , 2nd device own body diode: $V_{GS} = 0$ V

$$E = f(I_{DS})$$

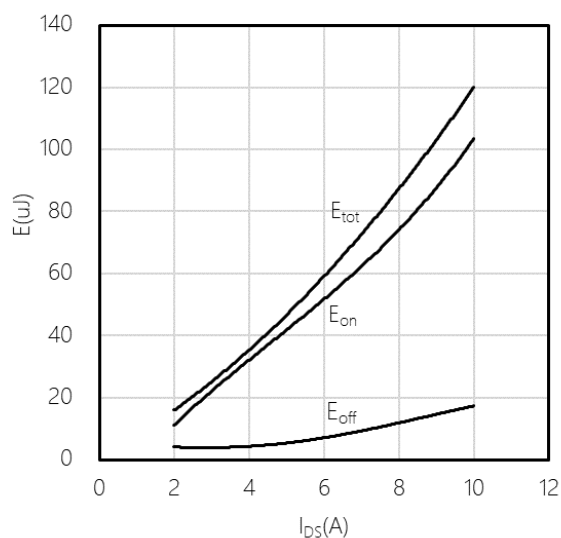
$V_{GS} = 0/15$ V, $R_{G(ext)} = 2.2$ Ω, $T_{VJ} = 25$ °C, $V_{DS} = 400$ V



Typical switching energy losses as a function of I_{DS} , 2nd device own body diode: $V_{GS} = 0$ V

$$E = f(I_{DS})$$

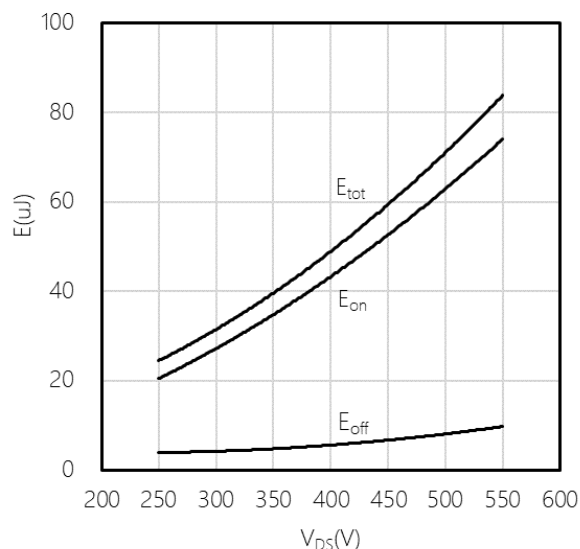
$V_{GS} = 0/15$ V, $R_{G(ext)} = 2.2$ Ω, $T_{VJ} = 175$ °C, $V_{DS} = 400$ V



Typical switching energy losses as a function of V_{DS} , 2nd device own body diode: $V_{GS} = 0$ V

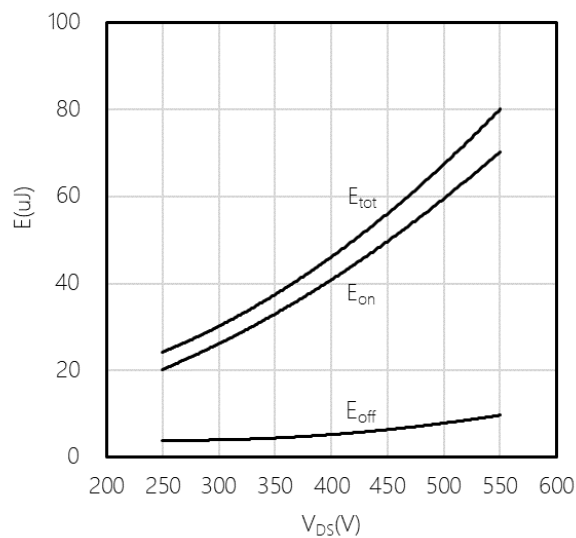
$$E = f(V_{DS})$$

$V_{GS} = 0/15$ V, $R_{G(ext)} = 2.2$ Ω, $T_{VJ} = 25$ °C, $I_{DS} = 5$ A

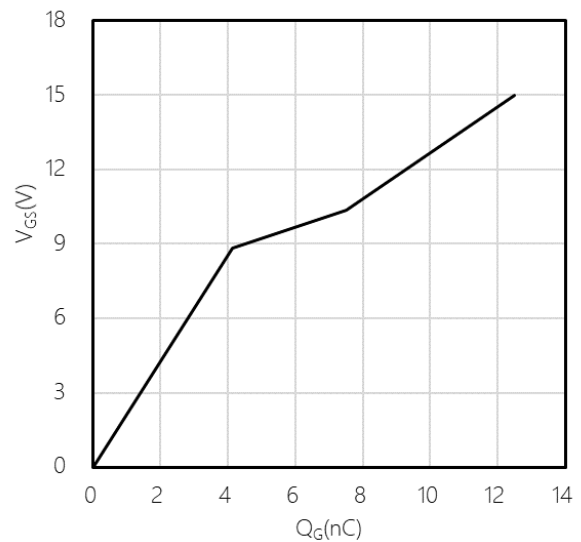
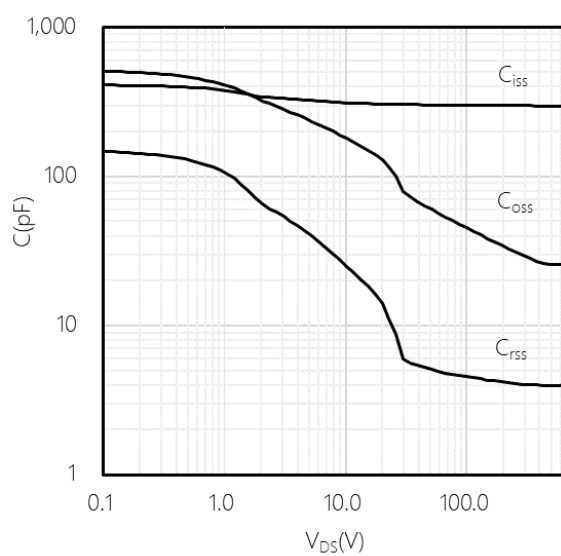


Typical switching energy losses as a function of V_{DS} ,
2nd device own body diode: $V_{GS} = 0\text{ V}$

$$E = f(V_{DS})$$

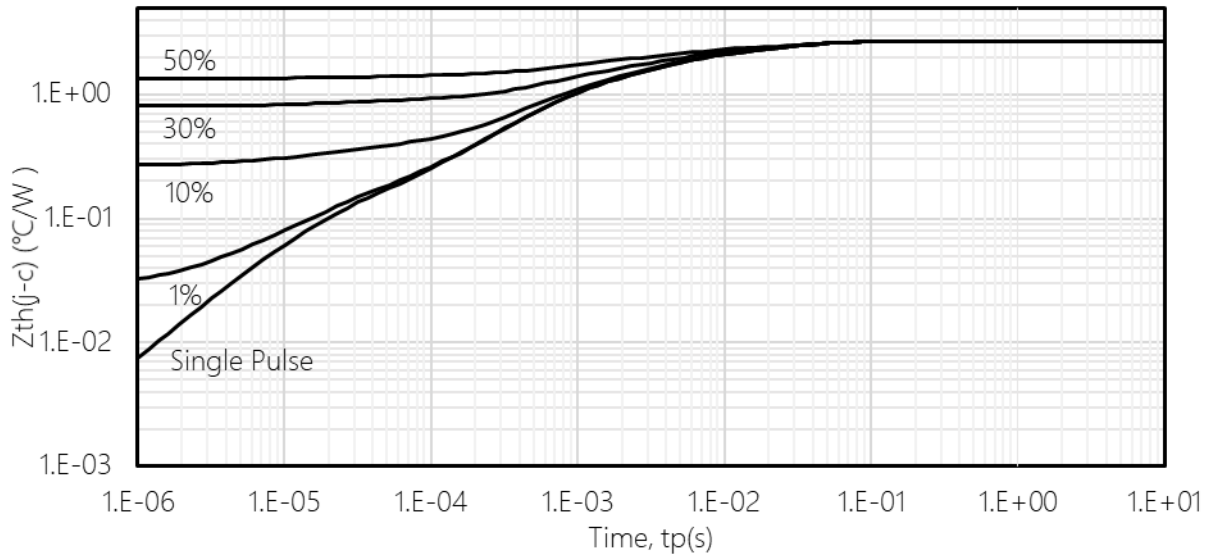
 $V_{VGS} = 0/15\text{ V}$, $R_{G(ext)} = 2.2\ \Omega$, $T_{VJ} = 175\ ^\circ\text{C}$, $I_{DS} = 5\text{ A}$

Typical gate charge
 $V_{GS} = f(Q_G)$, $I_{DS} = 5\text{ A}$, $V_{DS} = 400\text{ V}$

turn-on pulse


Typical capacitance as a function of drain-source voltage
 $C = f(V_{DS})$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$


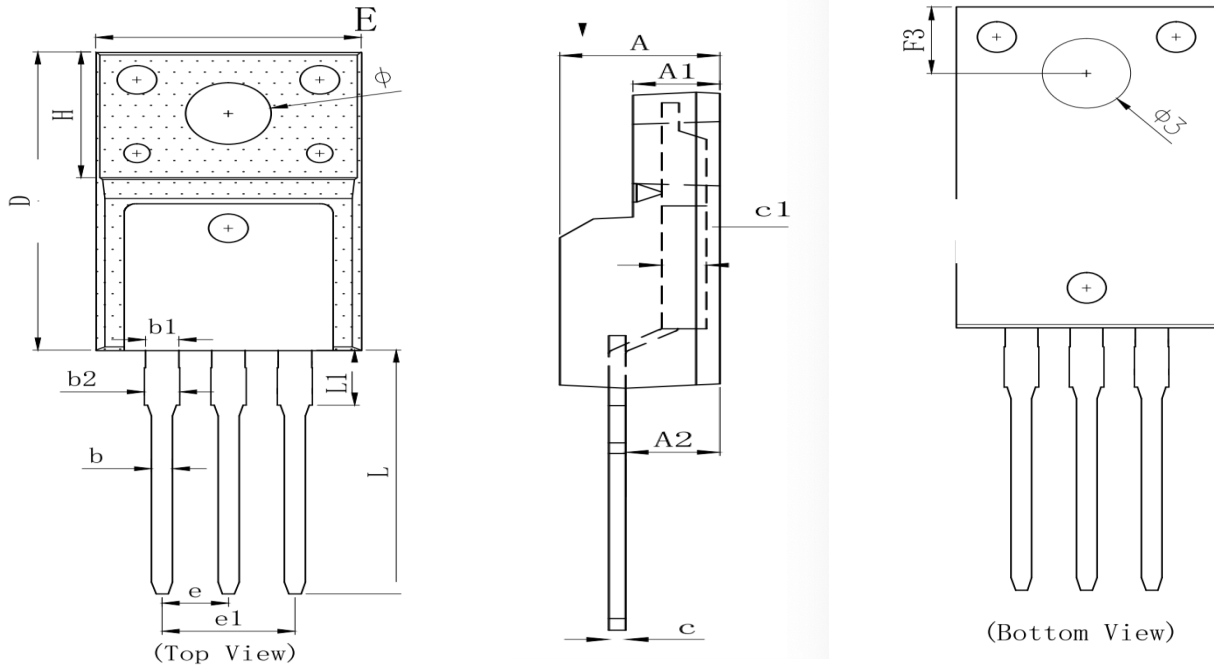
Transient thermal resistance (MOSFET)

$(Z_{th(j-c,max)} = f(t_p), \text{ Parameter } D = t_p/T$



Package Dimensions

Mechanical Dimensions for TO-220F



SYMBOL	MILLIMETER		
	MIN	Typ.	MAX
A	4.500	4.700	4.900
A1	2.340	2.540	2.740
A2	2.560	2.760	2.960
b	0.700	0.800	0.950
b1	1.180	1.280	1.430
b2	1.250	1.350	1.550
c	0.400	0.500	0.650
c1	1.200	1.300	1.350
D	15.570	15.870	16.170
H	6.700 REF		
E	9.960	10.160	10.360
e	2.540 BSC		
e1	5.080 BSC		
L	12.680	12.980	13.280
L1	2.780	2.930	3.080
F3	3.150	3.300	3.450
ϕ	3.030	3.180	3.450
$\phi 3$	3.150	3.450	3.650